lecute Classification			Applicant(s)/Pat	Applicant(s)/Patent under Reexamination	ion
issue classification			CHIARELLO ET AL.	AL.	
	Examiner Qian Ph.D., Celine X		Art Unit 1636		
ORIGINAL	INAL	INTE	RNATIONAL	INTERNATIONAL CLASSIFICATION	N
CLASS	SUBCLASS	CLAIMED	Q:	NON-CLAIMED	VIMED
536	25.3	C 0 7 H	21 / 00		
CROSS REFERENCE(S)	ERENCE(S)	<u> </u>			
CLASS SUBCLASS (O	SUBCLASS (ONE SUBCLASS PER BLOCK)				
(Assistan/ Examiner)		C HG NAIC RIVERS		Total Claims Allowed:	Allowed:
(Legal Instruments Examiner) 9(807)	Celine Qian (Primary Examiner)	ر بن ا	3/2168	O.G. Print Claim(s) 1	O.G. Print Figure None

U.S. Patent and Trademark Office

Part of Paper No.